

Search Notes

Application/Control No.

10/712,778

Examiner

Phi D. A

Applicant(s)/Patent under
Reexamination

MEIJER ET AL.

Art Unit

3637

SEARCHED

Class	Subclass	Date	Examiner
52	282.3	11/23/2005	PA
	271		
	285.1		
	285.4		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PA		